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# 承认规格书

种类:功率电感

系列号: \_HXNR6020N-Series

客户料号:\_\_\_\_\_

客户承认栏				
承认日期	年	月	日	

(贵司承认后请签署一份返回华信安电子,谢谢!)

# 厦门华信安电子科技有限公司技术质量部

承 认	确认	作成
龙梅	梁峰	王亮

TEL: 0592-6301603 FAX: 0592-5205265 Http: www.xmisnd.com

# Power Inductor

**HXNR6020N-SERIES** 

	ECN HISTORY LIST								
REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN				
1.0	16/07/05	新 發 行	龙梅	梁峰	王亮				
備									
註									

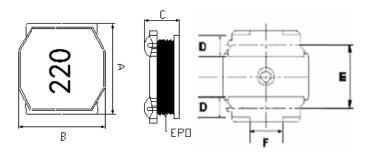
# **Power Inductor**

**HXNR6020N-SERIES** 

#### 1. Features

- 1. This specification applies Low Profile Power Inductors.
- 2. 100% Lead(Pb) & Halogen-Free and RoHS compliant.

#### 2. Dimension

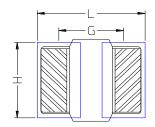


Series	A(mm)	B(mm)	C(mm)	D(mm)	E(mm)	F(mm)
HXNR6020N	6.0±0.2	6.0±0.2	2.0 max	1.35±0.2	4.6±0.3	4.0±0.2

# Halogen-free



#### **Recommendend Land pattern**



L(mm)	G(mm)	H(mm)	
6.3	4.7	5.7	

### 3. Part Numbering

HXNR 6020 N - 1R0 Y
A B C D E

- A: Series
- B: Dimension
- C: Control S/N
- D: Inductance 1R0=1.0uH
- E: Inductance Tolerance M=±20%; Y=±30%

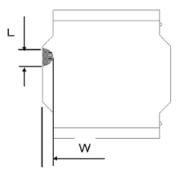
## 4. Specification

ISND Part Number	Inductance (uH)	Tolerance (%)	Test Frequency (Hz)	SRF (MHz) min.	DCR (Ω) ±20%	I sat (A)	I rms (A)
HXNR6020N-1R0Y	1.0	±30%	1V100K	110	0.020	5.20	3.80
HXNR6020N-1R5Y	1.5	±30%	1V100K	93	0.026	4.30	3.60
HXNR6020N-2R2Y	2.2	±30%	1V100K	73	0.034	3.20	2.90
HXNR6020N-3R3Y	3.3	±30%	1V100K	55	0.040	2.80	2.75
HXNR6020N-4R7M	4.7	±20%	1V100K	43	0.058	2.40	2.15
HXNR6020N-6R8M	6.8	±20%	1V100K	30	0.085	2.00	1.80
HXNR6020N-100M	10	±20%	1V100K	18	0.125	1.90	1.60
HXNR6020N-150M	15	±20%	1V100K	16	0.160	1.60	1.30
HXNR6020N-220M	22	±20%	1V100K	11	0.290	1.25	0.95
HXNR6020N-330M	33	±20%	1V100K	10	0.340	1.00	0.80
HXNR6020N-470M	47	±20%	1V100K	9	0.400	0.85	0.72

Note:

 $\mbox{Isat}: \mbox{Based on inductance change} \quad (\, \triangle \mbox{L/L0} : \leq \mbox{-30\%} \,) \, \, @ \mbox{ ambient temp. } 25\%$ 

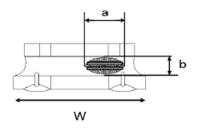
#### Core chipping



Туре	L	w
HXNR6020N	1.5mm Max.	1.5mm Max.

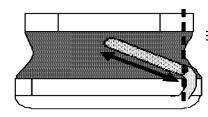
Void\_appearance tolerance Limit

The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension. Size of voids occurring to coating resin is specified below.



External appearance criterion for exposed wire

Exposed end of the winding wire at the secondary side should be 3mm and below.

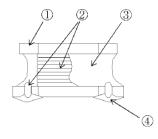


Exposed wire tolerance limit of coating resin part on product side.

Size of exposed wire occurring to coating resin is specified below.

- 1. Width direction ( dimension a ) : Acceptable when a  $\leq$  w/2 Nonconforming when a > w/2
- 2. Length direction (dimension b): Dimension b is not specified.
- 3. When total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, that is acceptable.

#### 5. Material List



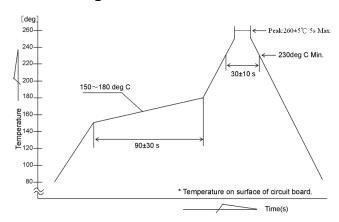
No.	Item	Material	
1	Core	Ni-Zn ferrite	
2	Wire	Copper Wire	
3	Coating	Ероху	
4	Solder	Lead free	

# 6. Reliability and Test Condition

Item	Performance	Test Method and Remarks
Operating Temperature	- 25 ~ +125℃.	Including self-generated heat
Storage Temperature	-40 ~ +85℃. - 5 to 40℃ for the product with taping.	
Rated current		
Inductance (L)	Within the specified tolerance	LCR Meter: HP 4285A or equivalent, 100kHz, 1V
DC Resistance		DC Ohmmeter: HIOKI3227 or equivalent
Temperature characteristics	Inductance change: Within±20%	Measurement of inductance shall be taken at temperature rang within–25°C to +85°C. With reference to inductance value at+20 °C,change rate shall be calculated. Measurement of inductance shall be taken at temperature rang within–40°C to +125°C. With reference to inductance value at+20 °C,change rate shall be calculated.
Resistance to flexure substrate	No damage.	The test samples shall be soldered to the testing board by the reflow.  As illustrated below, apply force in the direction of the arrow indicating until deflection of the test board reaches to 2mm.  Board  Res  Board  15 ± 2  Substrate size : 100x40x1.0  Substrate material : glass epoxy-resin Solder cream thickness : 0.15
Adhesion of Terminal electrode	Shall not come off PC board.	The test samples shall be soldered to the testing board and by the reflow.  10 N, 5 s  Applied force: 10 N to X and Y directions.  Duration: 5s  Solder cream thickness: 0.15
Resistance to Vibration	Inductance change: Within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow. Then it shall be submitted to below test conditions. Frequency: 10-55Hz Total Amplitude: 1.5mm (May not exceed acceleration 196m/S2) Sweeping Method:10Hz to 55Hz to 10Hz for 1min. Time: 2 hours each in X,Y, and Z Direction. Recovery: At least 2hrs of recovery under the standard condition after the test, followed by the measurement within 48hrs.
Solderability	At least 90% of surface of terminal electrode is covered by new solder.	The test samples shall be dipped in flux, and then immersed in molten solder as shown in below. Flux: methanol solution containing rosin 25% Solder temperature: 245±5°C Time: 5±1.0 sec. Immersion depth: All sides of mounting terminal shall be immersed.

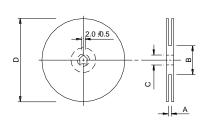
Item	Performance		Test Method and Remarks				
Resistance to soldering		The test sample shall be exposed to reflow over for 40 seconds, 2 times seconds, 2 times.  Test board thickness: 1.0mm Test board material: glass epoxy-resin					
Thermal shock		reflow. The test samp for specified to sequence.	oles shall be soldered to oles shall be placed at a time by step 1 to step 4 ure cycles shall be repe	specified tempera as shown below	ature in		
Thermal Shock		Phase	Temperature(℃)				
		1	-40±3℃	30±3			
		2	RoomTemp	Within 3			
		3	85±2°C	30±3			
		4	RoomTemp	Within 3	]		
Damp heat life test	soldered to t The test san specified ter Temperature		thod and Remarks The test samples shall be to the test board by the reflow. samples shall be placed in thermostatic oven set at a temperature and humidity as shown in below. ture: 60±2°C r: 90-95%RH i0+24/-0 hrs				
Loading under damp heat life test		reflow. The test samp specified temp current contin Temperature: Humidity: 90~	95%RH nt: Rated current	hermostatic oven and applied the ra	set at		
Low temperature life test		reflow.	-40±2℃				
Loading at high temperature life test		reflow. Temperature:	nt: Rated current	o the test board b	y the		

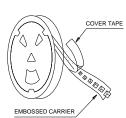
# 7. Soldering



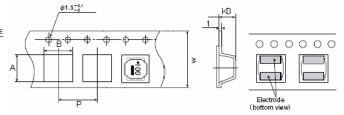
## 8. Packaging Information

#### (1) Reel Dimension





#### (2) Tape Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
HXNR6020N	13.5±1.0	80±2.0	13±0.5	330±3.0

Туре	A(mm)	B(mm)	Ko(mm)	P(mm)	W(mm)	t(mm)
HXNR6020N	6.3±0.1	6.3±0.1	3.1±0.1	8.0±0.1	12±0.3	0.4±0.1

#### (3) Packaging Quantity

Туре	Chip / Reel
HXNR6020N	2000

#### **Application Notice**

- Storage Conditions
- To maintain the solderability of terminal electrodes:
- 1. ISND products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 2. Temperature and humidity conditions: Less than 40 ℃ and 60% RH.

  3. Recommended products should be used within 12 months form the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- $2. \ The \ use \ of \ tweezers \ or \ vacuum \ pick \ up \ is \ strongly \ recommended \ for \ individual \ components.$
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

单击下面可查看定价,库存,交付和生命周期等信息

>>ISND(华信安)